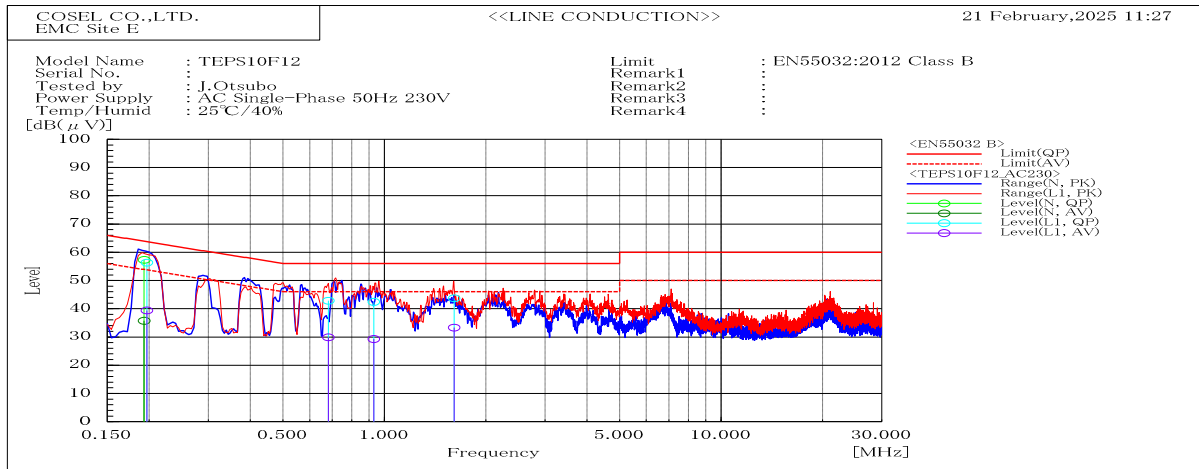
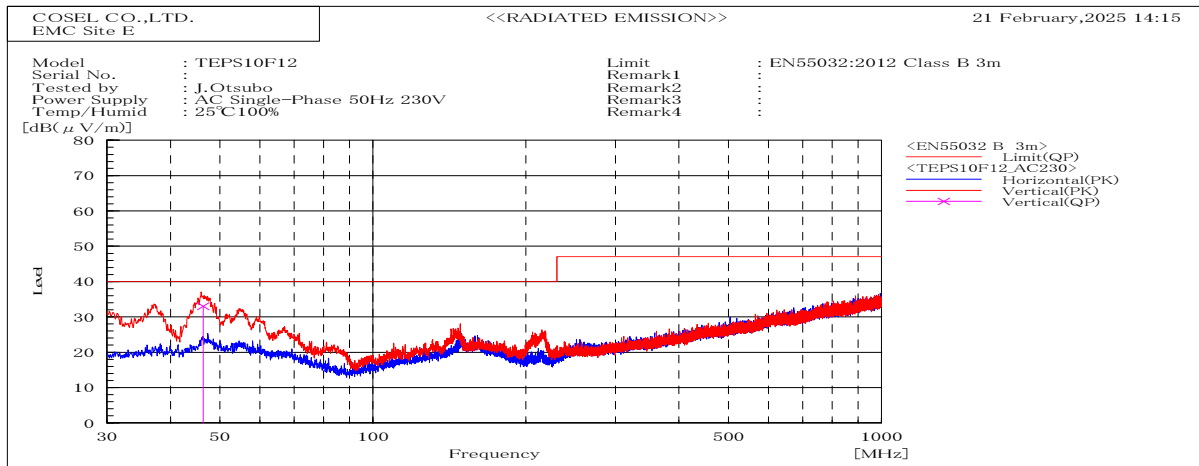


DATA SHEET		Date	24-Mar-25
Model	TEPS10F12	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma



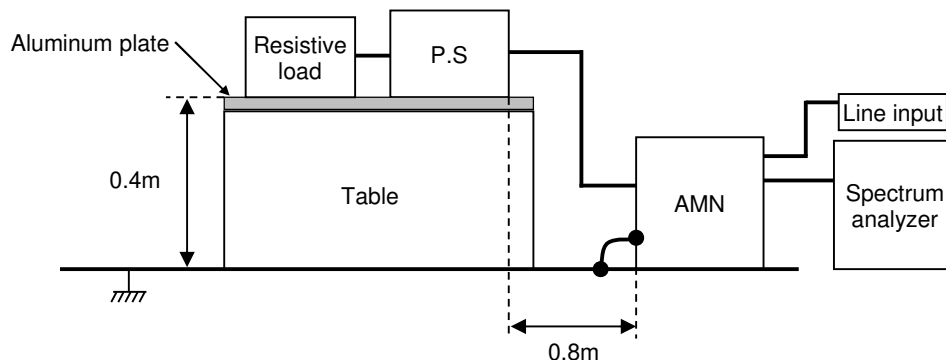
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.197	L1	56.3	39.4	63.7	53.7	7.4	14.3	Pass	
0.681	L1	42.8	29.9	56	46	13.2	16.1	Pass	
0.931	L1	42.5	29.3	56	46	13.5	16.7	Pass	
1.611	L1	43.7	33.4	56	46	12.3	12.6	Pass	
0.193	N	57.3	35.7	63.9	53.9	6.6	18.2	Pass	



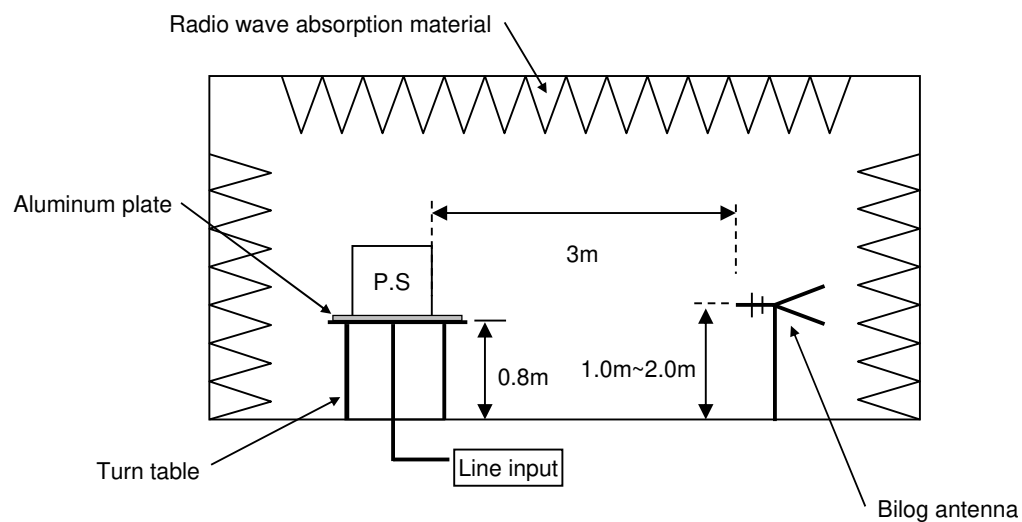
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Limit dB(μV/m)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV						
46.408	V	Stable	33	40	40	7	Pass	100.2	188.8	

DATA SHEET		Date	24-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



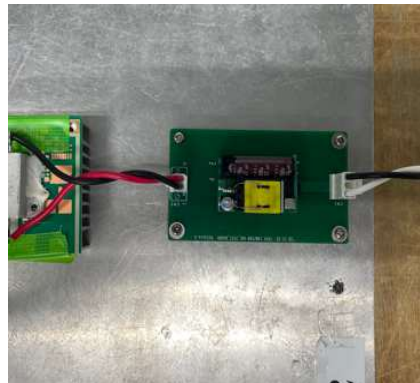
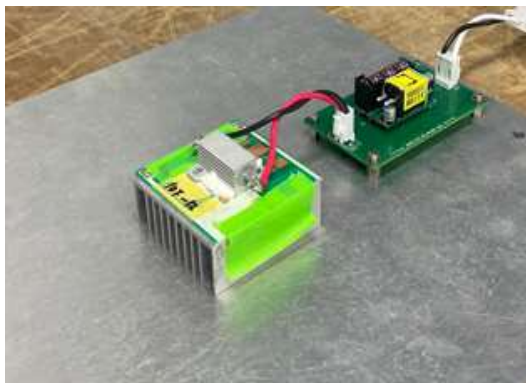
2. Radiated emission



Conditions

Test : EMI
Model Name : TEPS10F12

1.LINE CONDUCTION



2.RADIATED EMISSION

